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Figure 1 Low room-temperature resistivity for 26 – 55 nm Nb<sub>x</sub>Ti<sub>1-x</sub>N films prepared with varying Nb/(Nb+Ti) cycle ratio. The approximately linear rise of resistivity with Nb content suggests good mixing of the Nb<sub>x</sub>Ti<sub>1-x</sub>N constituents.

Figure 2 Nb<sub>x</sub>Ti<sub>1-x</sub>N bulk composition measured by XPS for films prepared with varying Nb/(Nb+Ti) cycle ratio demonstrating accurate composition control.

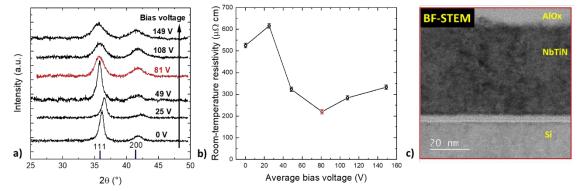


Figure 3 Influence of substrate bias voltage on crystallinity and conductivity. **a)** X-ray diffractograms and **b)** room-temperature resistivity of 28 - 35 nm  $Nb_{0.5}Ti_{0.5}N$  films prepared with Nb/(Nb+Ti) = 0.5 cycle ratio and varying bias voltage. **c)** BF-STEM image of a cross-section of a 49 nm  $Nb_{0.5}Ti_{0.5}N$  film prepared with Nb/(Nb+Ti) = 0.5 cycle ratio and 90 V bias. The similar settings amongst the three images are indicated in red.